## Search Notes



1	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/539,731	LEE ET AL.
	Examiner	Art Unit

2416

Sai-Ming Chan

SEARCHED				
Class	Subclass	Date	Examiner	
370	352	12/11/2007	sc	
370	466,469	12/15/2008	sc	
370	497	12/15/2008	sc	
370	395.5	12/19/2008	sc	
370	395.52	12/19/2008	sc	

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
370	395.5	12/19/2008	sc	
370	395.52	12/19/2008	sc	
370	466,469	12/15/2008	sc	
370 / 497		12/19/2008	sc	

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
EAST Image and keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, and IBM, TDB (see attached search strategy)	12/11/2007	sc
Inventor name and Assignee search in PALM EXPO and EAST	12/11/2007	sc
Updated search	12/15/2008	sc
Updated search	12/19/2008	sc